2SK3158

Silicon N Channel MOS FET High Speed Power Switching

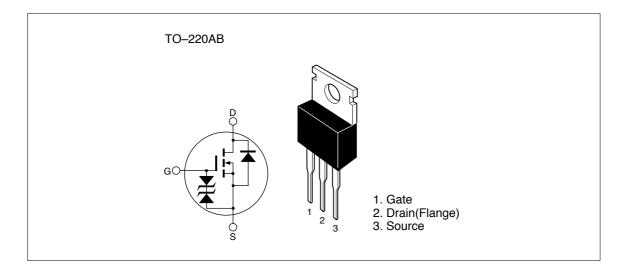
HITACHI

Target Specification 2nd. Edition December 1998

Features

- Low on-resistance $R_{DS} = 35 m\Omega \text{ typ.}$
- · High speed switching
- 4V gate drive device can be driven from 5V source

Outline





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Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit	
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	150	V	
Gate to source voltage	$V_{\sf GSS}$	±20	V	
Drain current	I _D	30	A	
Drain peak current	Note1 D(pulse)	120	A	
Body-drain diode reverse drain current	I _{DR}	30	A	
Avalanche current	Note3	30	A	
Avalanche energy	E _{AR} Note3	67	mJ	
Channel dissipation	Pch Note2	100	W	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Note: 1. PW \leq 10 μ s, duty cycle \leq 1 %

2. Value at $Tc = 25^{\circ}C$

3. Value at Tch = 25° C, Rg $\geq 50\Omega$

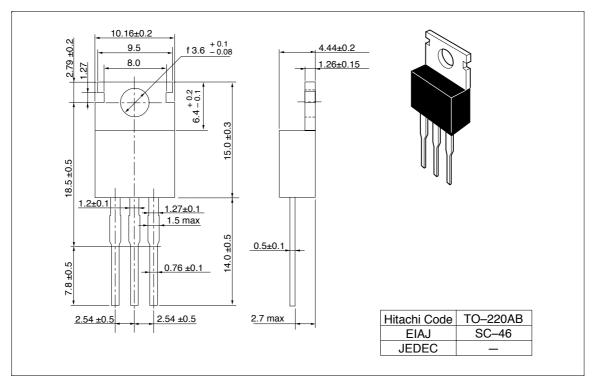
Electrical Characteristics (Ta = 25°C)

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown	V _{(BR)DSS}	150	_	_	V	$I_{D} = 10 \text{mA}, \ V_{GS} = 0$
voltage						
Gate to source breakdown	$V_{(BR)GSS}$	±20	_	_	V	$I_{G} = \pm 100 \mu A, V_{DS} = 0$
voltage						
Gate to source leak current	$I_{\rm GSS}$	_	_	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0$
Zero gate voltege drain current	t I _{DSS}		_	10	μΑ	$V_{DS} = 150 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	1.0	_	2.5	V	$I_D = 1 \text{mA}, V_{DS} = 10 \text{V}$
Static drain to source on state	R _{DS(on)}	_	35	45	mΩ	$I_{\rm D} = 15 A, V_{\rm GS} = 10 V^{\rm Note4}$
resistance	R _{DS(on)}		42	75	mΩ	$I_{\rm D} = 15 A, V_{\rm GS} = 4 V^{\rm Note4}$
Forward transfer admittance	ly _{fs} l	18	30	_	S	$I_{D} = 15A, V_{DS} = 10V^{Note4}$
Input capacitance	Ciss	_	2600	_	pF	V _{DS} = 10V
Output capacitance	Coss		820	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	350	_	pF	f = 1MHz
Turn-on delay time	t _{d(on)}	_	25	_	ns	$I_{\rm D} = 15A, V_{\rm GS} = 10V$
Rise time	t _r		180	_	ns	$R_L = 2\Omega$
Turn-off delay time	t _{d(off)}	_	600	_	ns	_
Fall time	t _f	_	280	_	ns	<u> </u>
Body-drain diode forward	V _{DF}	_	0.95	_	V	$I_F = 30A, V_{GS} = 0$
voltage						
Body-drain diode reverse	t _{rr}		110	_	ns	$I_F = 30A, V_{GS} = 0$
recovery time						$diF/dt = 50A/\mu s$

Note: 4. Pulse test

Package Dimensions

Unit: mm



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Semiconductor & IC Div. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

For further information write to:

Hitachi Semiconductor (America) Inc. 2000 Sierra Point Parkway Dornacher Straße 3 Brisbane, CA. 94005-1897 D-85622 Feldkirchen

Tel: 800-285-1601 Fax:303-297-0447

Continental Europe München Tel: 089-9 91 80-0 Fax: 089-9 29 30-00

Hitachi Europe GmbH Hitachi Europe Ltd. Electronic Components Div. Northern Europe Headquarters Hitachi Tower Whitebrook Park Lower Cookham Road Maidenhead Berkshire SI 6 8YA United Kingdom Tel: 01628-585000 Fax: 01628-585160

Hitachi Asia Pte. Ltd. Singapore 049318 Tel: 535-2100 Fax: 535-1533

Hitachi Asia (Hong Kong) Ltd. 16 Collyer Quay #20-00 Unit 706, North Tower, World Finance Centre. Harbour City, Canton Road Tsim Sha Tsui, Kowloon Hona Kona Tel: 27359218 Fax: 27306071

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